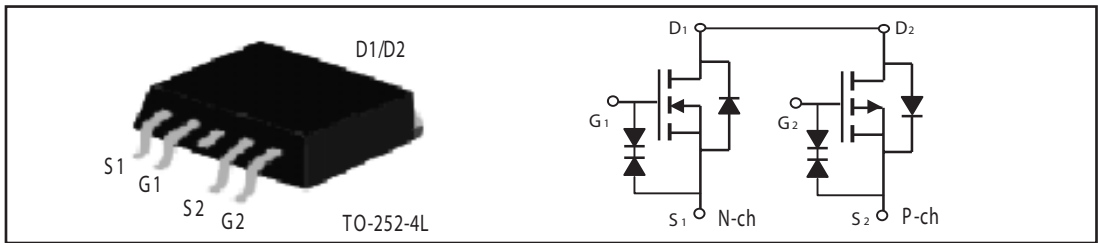




Dual Enhancement Mode Field Effect Transistor (N and P Channel)

PRODUCT SUMMARY (N-Channel)		
V _{DS}	I _D	R _{DS(ON)} (mΩ) Max
40V	16A	29 @ V _{GS} = 10V
		39 @ V _{GS} = 4.5V

PRODUCT SUMMARY (P-Channel)		
V _{DS}	I _D	R _{DS(ON)} (mΩ) Max
-40V	-12A	47 @ V _{GS} = -10V
		64 @ V _{GS} = -4.5V



ABSOLUTE MAXIMUM RATINGS (T_A=25°C unless otherwise noted)

Parameter		Symbol	N-Channel	P-Channel	Unit
Drain-Source Voltage		V _{DS}	40	-40	V
Gate-Source Voltage		V _{GS}	±20	±20	V
Drain Current-Continuous @ T _c	25°C	I _D	16	-12	A
	70°C		13.8	-10	A
-Pulsed ^a		I _{DM}	50	-50	A
Drain-Source Diode Forward Current		I _S	8	-6	A
Maximum Power Dissipation	T _c = 25°C	P _D	11		W
	T _c = 70°C		7.7		
Operating Junction and Storage Temperature Range		T _J , T _{STG}	-55 to 175		°C

THERMAL CHARACTERISTICS

Thermal Resistance, Junction-to-Case	R _{θJC}	13.6	°C/W
Thermal Resistance, Junction-to-Ambient	R _{θJA}	120	°C/W

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N-Channel ELECTRICAL CHARACTERISTICS ($T_A = 25\text{ }^{\circ}\text{C}$ unless otherwise noted)

Parameter	Symbol	Condition	Min	Typ ^c	Max	Unit
OFF CHARACTERISTICS						
Drain-Source Breakdown Voltage	BV_{DSS}	$V_{GS}=0V, I_D=250\mu A$	40			V
Zero Gate Voltage Drain Current	I_{DSS}	$V_{DS}=32V, V_{GS}=0V$			1	μA
Gate-Body Leakage	I_{GSS}	$V_{GS}=\pm 20V, V_{DS}=0V$			± 10	μA
ON CHARACTERISTICS^a						
Gate Threshold Voltage	$V_{GS(th)}$	$V_{DS}=V_{GS}, I_D=250\mu A$	1	1.8	3	V
Drain-Source On-State Resistance	$R_{DS(ON)}$	$V_{GS}=10V, I_D=8A$		21	29	m ohm
		$V_{GS}=4.5V, I_D=6A$		29	39	m ohm
On-State Drain Current	$I_{D(ON)}$	$V_{DS}=5V, V_{GS}=4.5V$	20			A
Forward Transconductance	g_{FS}	$V_{DS}=10V, I_D=8A$		15		S
DYNAMIC CHARACTERISTICS^b						
Input Capacitance	C_{ISS}	$V_{DS}=20V, V_{GS}=0V$ $f=1.0MHz$		735		pF
Output Capacitance	C_{OSS}			120		pF
Reverse Transfer Capacitance	C_{RSS}			70		pF
Gate resistance	R_g	$V_{GS}=0V, V_{DS}=0V, f=1.0MHz$		0.36		ohm
SWITCHING CHARACTERISTICS^b						
Turn-On Delay Time	$t_{D(ON)}$	$V_{DD}=20V$ $I_D=3A$ $V_{GS}=10V$ $R_{GEN}=3\text{ ohm}$		13		ns
Rise Time	t_r			15		ns
Turn-Off Delay Time	$t_{D(OFF)}$			26		ns
Fall Time	t_f			10		ns
Total Gate Charge	Q_g	$V_{DS}=20V, I_D=8A, V_{GS}=10V$		15		nC
		$V_{DS}=20V, I_D=8A, V_{GS}=4.5V$		7.2		nC
Gate-Source Charge	Q_{gs}	$V_{DS}=20V, I_D=8A$		2.0		nC
Gate-Drain Charge	Q_{gd}	$V_{GS}=10V$		3.8		nC

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P-Channel ELECTRICAL CHARACTERISTICS ($T_A = 25\text{ }^{\circ}\text{C}$ unless otherwise noted)

Parameter	Symbol	Condition	Min	Typ ^c	Max	Unit
OFF CHARACTERISTICS						
Drain-Source Breakdown Voltage	BV_{DSS}	$V_{GS}=0V, I_D=-250\mu A$	-40			V
Zero Gate Voltage Drain Current	I_{DSS}	$V_{DS}=-32V, V_{GS}=0V$			-1	μA
Gate-Body Leakage	I_{GSS}	$V_{GS}=\pm 20V, V_{DS}=0V$			± 10	μA
ON CHARACTERISTICS^a						
Gate Threshold Voltage	$V_{GS(th)}$	$V_{DS}=V_{GS}, I_D=-250\mu A$	-1	-1.6	-3	V
Drain-Source On-State Resistance	$R_{DS(ON)}$	$V_{GS}=-10V, I_D=-6A$		39	47	m ohm
		$V_{GS}=-4.5V, I_D=-4A$		49	64	m ohm
On-State Drain Current	$I_{D(ON)}$	$V_{DS}=-5V, V_{GS}=-10V$	-20			A
Forward Transconductance	g_{FS}	$V_{DS}=-10V, I_D=-6A$		9		S
DYNAMIC CHARACTERISTICS^b						
Input Capacitance	C_{ISS}	$V_{DS}=-20V, V_{GS}=0V$ $f=1.0MHz$		920		pF
Output Capacitance	C_{OSS}			135		pF
Reverse Transfer Capacitance	C_{RSS}			75		pF
Gate resistance	R_g	$V_{GS}=0V, V_{DS}=0V, f=1.0MHz$		3.5		ohm
SWITCHING CHARACTERISTICS^b						
Turn-On Delay Time	$t_{D(ON)}$	$V_{DD}=-20V$ $I_D=-3A$ $V_{GS}=-10V$ $R_{GEN}=3\text{ ohm}$		12		ns
Rise Time	t_r			13		ns
Turn-Off Delay Time	$t_{D(OFF)}$			60		ns
Fall Time	t_f			25		ns
Total Gate Charge	Q_g	$V_{DS}=-20V, I_D=-6A, V_{GS}=-10V$		15		nC
		$V_{DS}=-20V, I_D=-6A, V_{GS}=-4.5V$		7.2		nC
Gate-Source Charge	Q_{gs}	$V_{DS}=-20V, I_D=-6A$		2		nC
Gate-Drain Charge	Q_{gd}	$V_{GS}=-10V$		4.0		nC

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ELECTRICAL CHARACTERISTICS ($T_A=25^{\circ}\text{C}$ unless otherwise noted)

Parameter	Symbol	Condition	Min	Typ ^c	Max	Unit
DRAIN-SOURCE DIODE CHARACTERISTICS^b						
Diode Forward Voltage	V_{SD}	$V_{GS} = 0\text{V}, I_S = 8\text{A}$ $V_{GS} = 0\text{V}, I_S = -6\text{A}$	N-Ch P-Ch	0.94 -0.87	1.2 -1.2	V

Notes

- a. Pulse Test: Pulse Width $\leq 300 \mu\text{s}$, Duty Cycle $\leq 2\%$.
- b. Guaranteed by design, not subject to production testing.

N-Channel

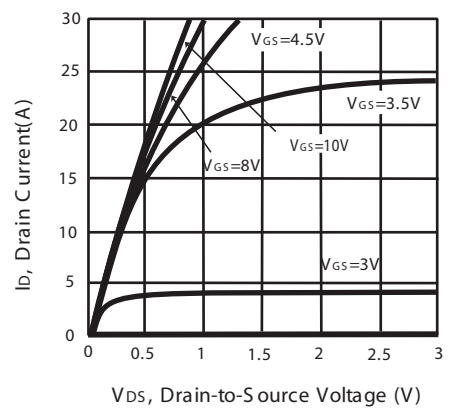


Figure 1. Output Characteristics

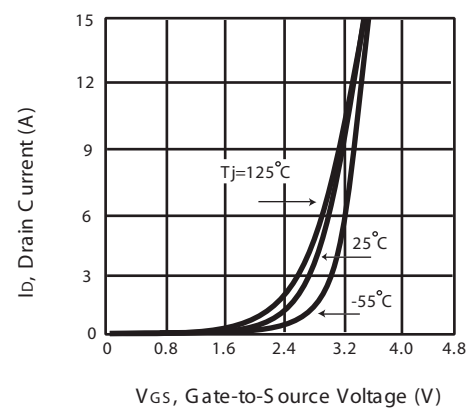


Figure 2. Transfer Characteristics

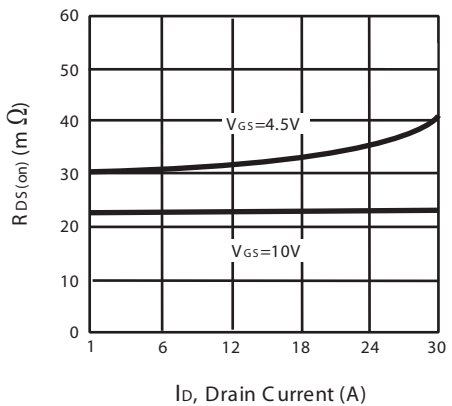


Figure 3. On-Resistance vs. Drain Current and Gate Voltage

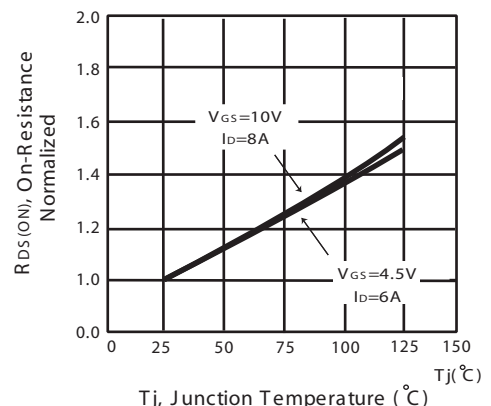


Figure 4. On-Resistance Variation with Drain Current and Temperature

STU407DH

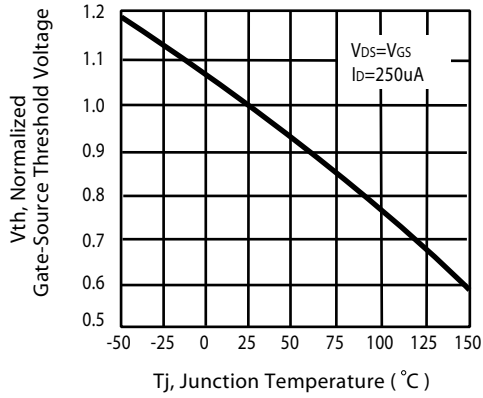


Figure 5. Gate Threshold Variation with Temperature

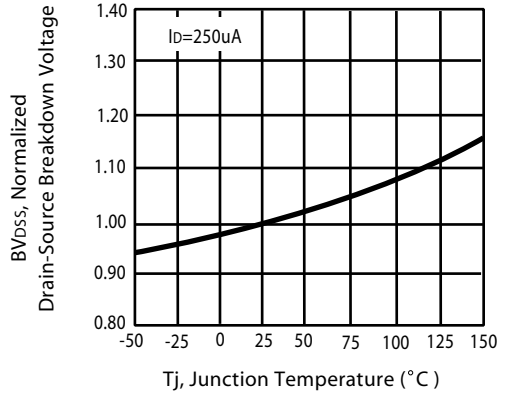


Figure 6. Breakdown Voltage Variation with Temperature

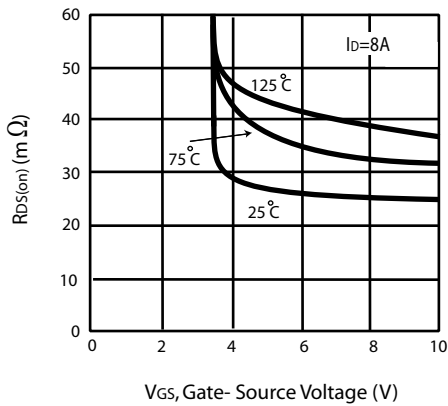


Figure 7. On-Resistance vs. Gate-Source Voltage

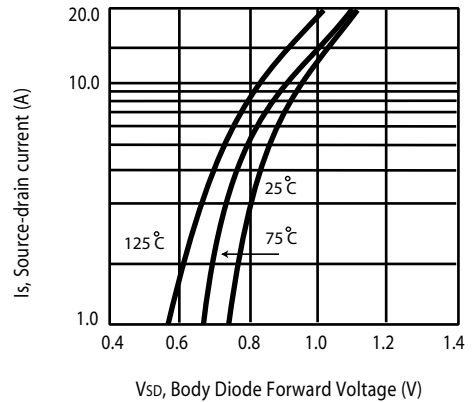


Figure 8. Body Diode Forward Voltage Variation with Source Current

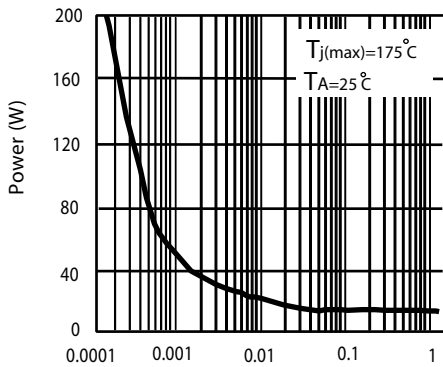
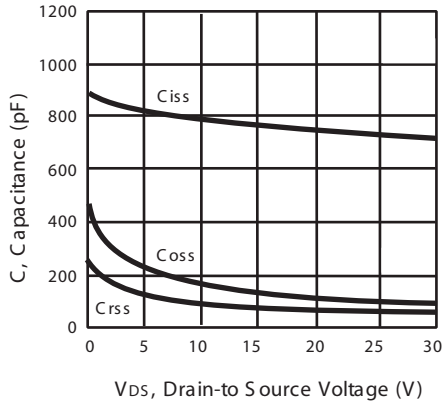


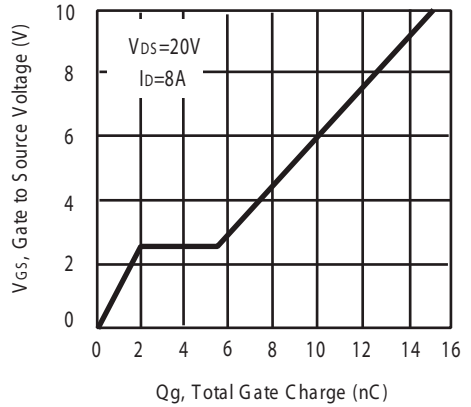
Figure 9. Single Pulse Power Rating Junction-to-Case

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V_{DS} , Drain-to Source Voltage (V)

Figure 10. Capacitance



Q_g , Total Gate Charge (nC)

Figure 11. Gate Charge

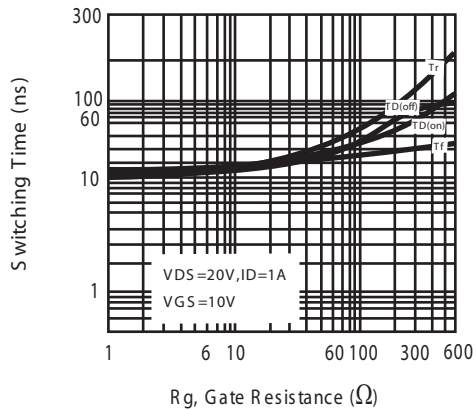


Figure 12. switching characteristics

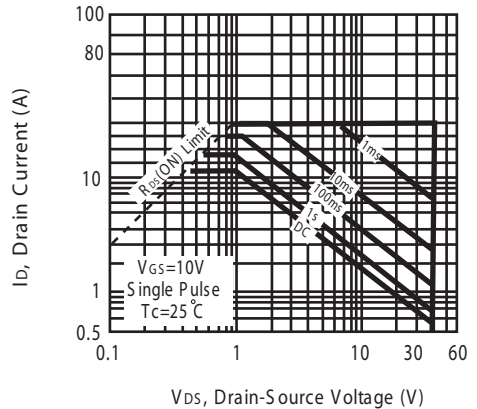


Figure 13. Maximum Safe Operating Area

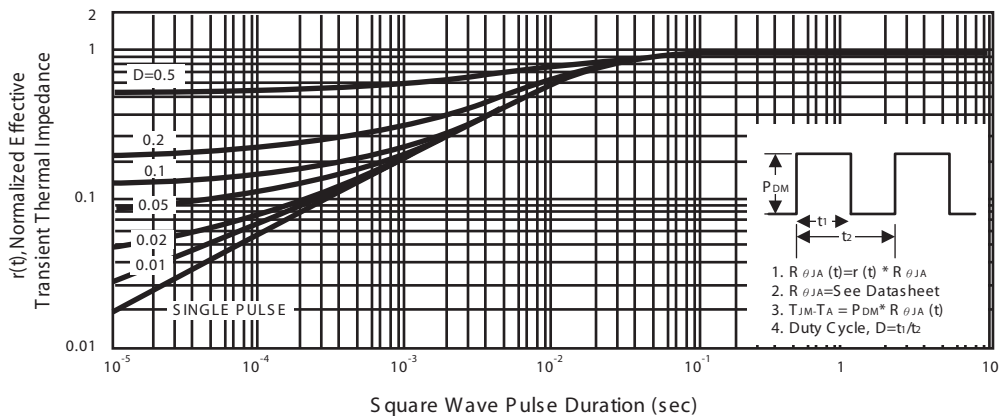


Figure 14. Normalized Thermal Transient Impedance Curve

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P-Channel

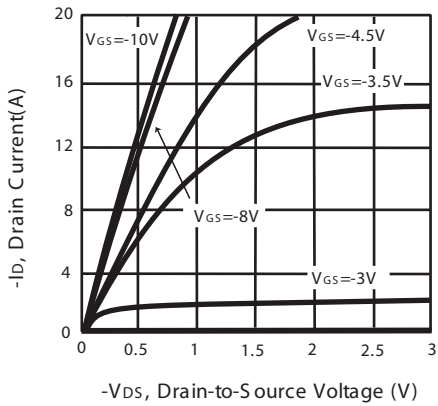


Figure 1. Output Characteristics

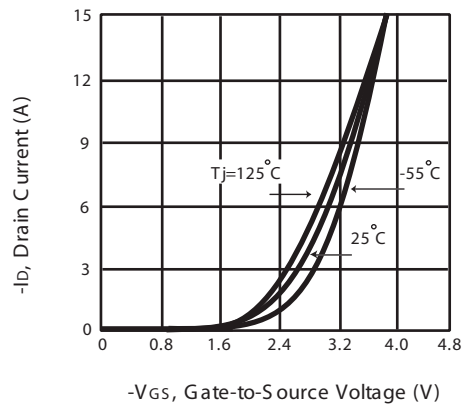


Figure 2. Transfer Characteristics

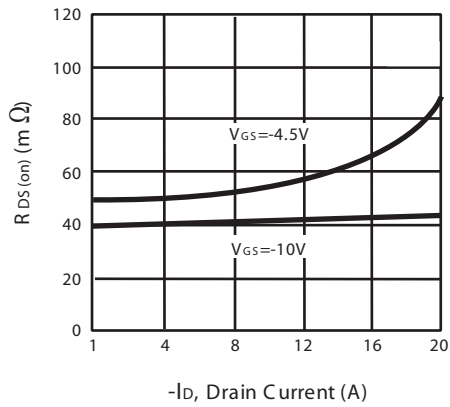


Figure 3. On-Resistance vs. Drain Current and Gate Voltage

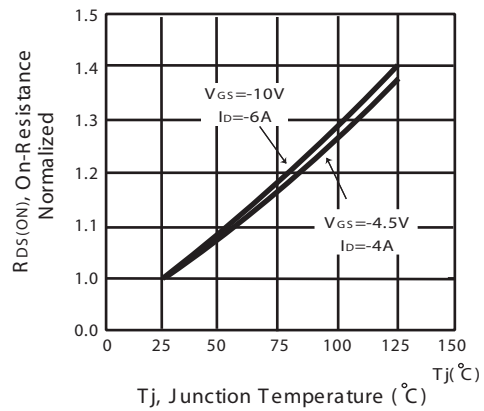


Figure 4. On-Resistance Variation with Drain Current and Temperature

STU407DH

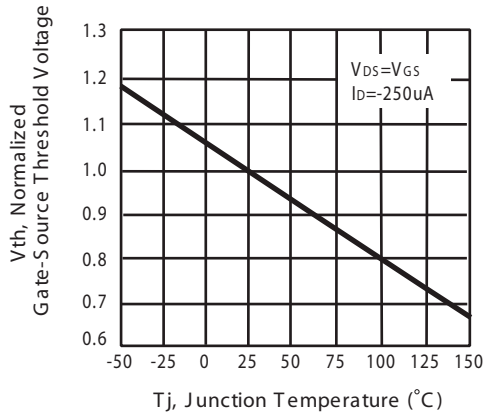


Figure 5. Gate Threshold Variation with Temperature

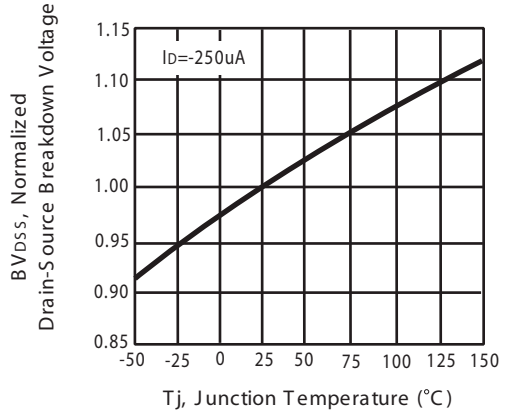


Figure 6. Breakdown Voltage Variation with Temperature

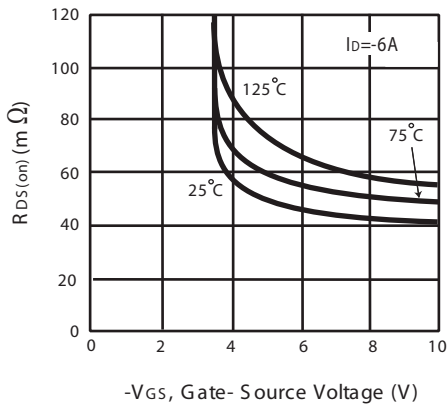


Figure 7. On-Resistance vs. Gate-Source Voltage

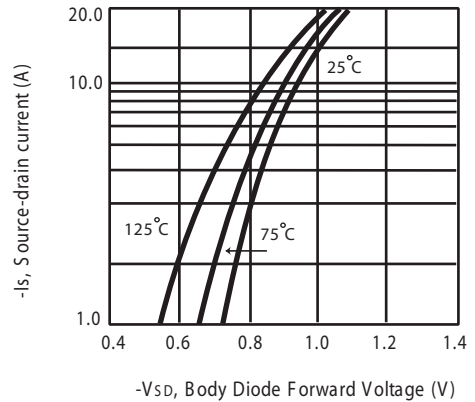


Figure 8. Body Diode Forward Voltage Variation with Source Current

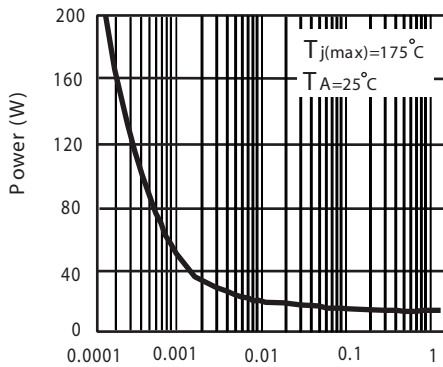


Figure 9. Single Pulse Power Rating Junction-to-Case

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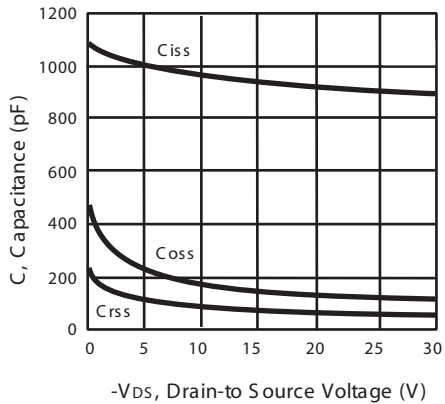


Figure 10. Capacitance

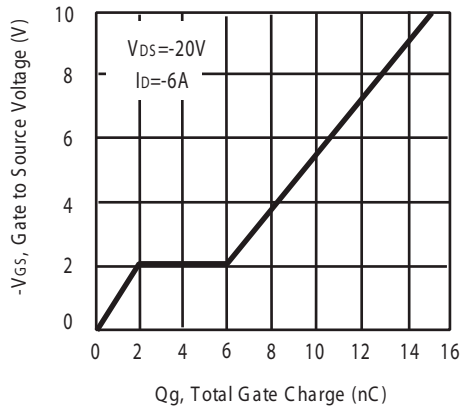


Figure 11. Gate Charge

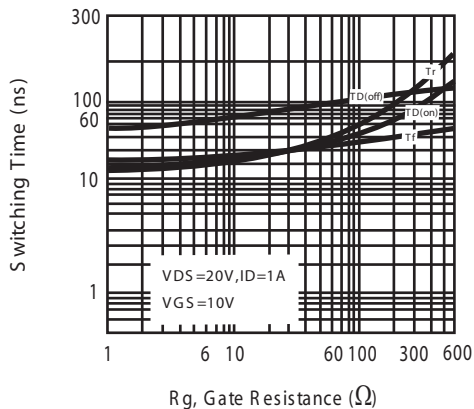


Figure 12. switching characteristics

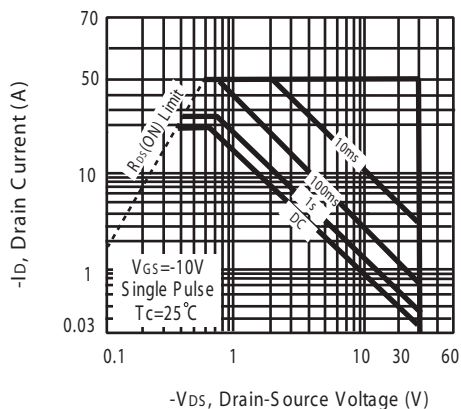


Figure 13. Maximum Safe Operating Area

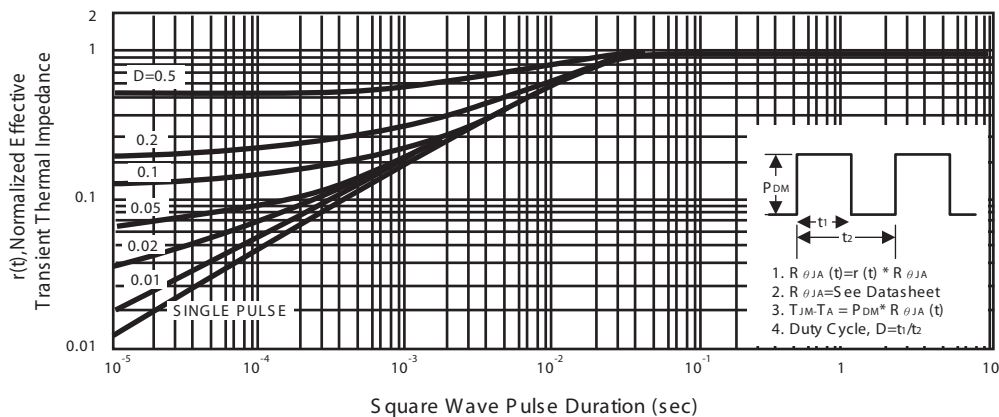
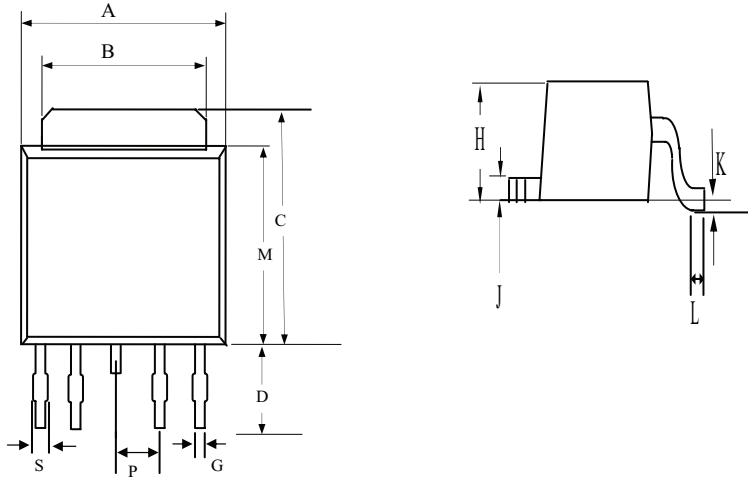


Figure 14. Normalized Thermal Transient Impedance Curve

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PACKAGE OUTLINE DIMENSIONS

TO-252-4L

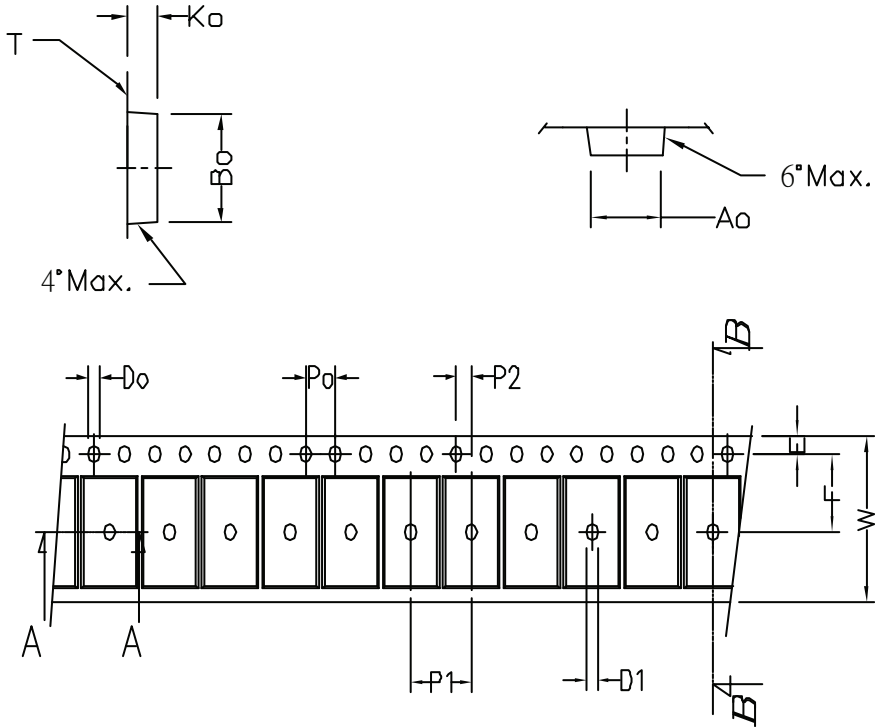


REF .	Millimeters	
	MIN	MAX
A	6.40	6.80
B	5.2	5.50
C	6.80	10.20
D	2.20	3.00
P	1.27 REF.	
S	0.50	0.80
G	0.40	0.60
H	2.20	2.40
J	0.45	0.60
K	0	0.15
L	0.90	1.50
M	5.40	5.80

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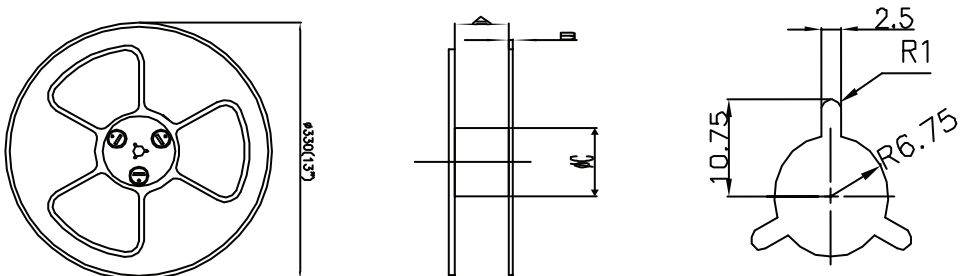
TO-252-4L Tape and Reel Data

TO-252-4L Carrier Tape



symbol	A ₀	B ₀	K ₀	P ₀	P ₁	P ₂	T
Spec	6.96±0.1	10.49±0.1	2.79±0.1	4.0±0.1	8.0±0.10	2.0±0.05	0.33±0.013
symbol	E	F	D ₀	D ₁	W	10P ₀	
Spec	1.75±0.1	7.5±0.05	1.55±0.05	1.5±0.25	16.0 ^{+0.3} _{-0.1}	40.0±0.2	

TO-252-4L Reel



UNIT:mm

Width of carrier tape	8	12	16	24	32	44	56
A±0.1	9.4	13.4	17.4	25.4	33.4	45.4	57.4
B	2.3	2.3	2.3	2.3	2.3	2.3	2.3
∅C	100	100	100	100	100	100	100